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| Notice of References Cited | Application/Control No. 10/766,665 | | Applicant(s)/Patent Under Reexamination LEE ET AL. | |
| | Examiner Tung X. Le | | Art Unit 2821 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------------|----------------|
| * | A | US-6,436,304 | 08-2002 | Nogami, Hiroshi | 216/79 |
| * | B | US-6,297,595 | 10-2001 | Stimson et al. | 315/111.51 |
| * | C | US-6,463,875 | 10-2002 | Chen et al. | 118/723I |
| * | D | US-5,952,978 | 09-1999 | VanVoorhies, Kurt Louis | 343/742 |
| * | E | US-6,350,347 | 02-2002 | Ishii et al. | 156/345.48 |
| * | F | US-6,842,147 | 01-2005 | Howald et al. | 343/701 |
| * | G | US-2003/0234744 | 12-2003 | Podger, James Stanley | 343/742 |
| * | H | US-2003/0201722 | 10-2003 | Appleyard, Nicholas John | 315/111.21 |
| * | I | US-2003/0189524 | 10-2003 | Wilcoxson et al. | 343/742 |
| * | J | US-2002/0018025 | 02-2002 | Matsuda et al. | 343/895 |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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